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APPLICANT Franz LAERMER

FILING DATE To be assigned GROUP To be assigned

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EXAMINER INITIAL	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE
/RD/	US 2002/074946 *	June 20, 2002	Tetsuya et al.		 	_i
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ſ	on considered, whether or not citation is in conforman	ce with M.P.E.P. 609; draw line through citation if not in	conformance and